

# AP70SL1K4BK2

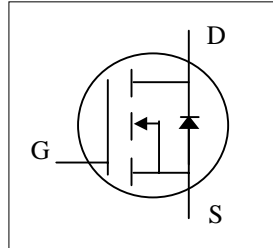
**Halogen-Free Product**



**Advanced Power  
Electronics Corp.**

*N-CHANNEL ENHANCEMENT MODE  
POWER MOSFET*

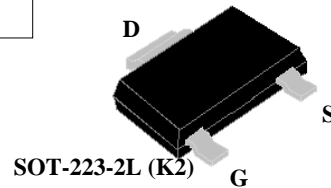
- ▼ 100% R<sub>g</sub> & UIS Test
- ▼ Fast Switching Characteristic
- ▼ Simple Drive Requirement
- ▼ RoHS Compliant & Halogen-Free



$BV_{DSS}$	700V
$R_{DS(ON)}$	1.4Ω
$I_D^3$	3.2A

## Description

AP70SL1K4B series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.



The SOT-223-2L package is specially designed for high voltage surface mount application with big Drain-to-Source pin space.

## Absolute Maximum Ratings @T<sub>j</sub>=25°C (unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	700	V
$V_{GS}$	Gate-Source Voltage	±20	V
$V_{GS}$	Gate-Source Voltage, AC (f > 1Hz)	±30	V
$I_D @ T_C=25^\circ C$	Drain Current, $V_{GS} @ 10V^3$	3.2	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	8.3	A
dv/dt	MOSFET dv/dt Ruggedness ( $V_{DS} = 0 \dots 400V$ )	20	V/ns
$P_D @ T_A=25^\circ C$	Total Power Dissipation <sup>6</sup>	2.78	W
$E_{AS}$	Single Pulse Avalanche Energy <sup>4</sup>	18	mJ
dv/dt	Peak Diode Recovery dv/dt <sup>5</sup>	15	V/ns
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Value	Units
R <sub>thj-a</sub>	Maximum Thermal Resistance, Junction-ambient <sup>6</sup>	45	°C/W



# AP70SL1K4BK2

## Electrical Characteristics @T<sub>j</sub>=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	700	-	-	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =1A	-	-	1.4	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2	-	5	V
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =20V, I <sub>D</sub> =1A	-	2.4	-	S
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =560V, V <sub>GS</sub> =0V	-	-	100	uA
I <sub>GSS</sub>	Gate-Source Leakage	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±1	uA
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =1.5A	-	11.2	18	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =480V	-	3	-	nC
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	V <sub>GS</sub> =10V	-	5	-	nC
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =400V	-	11	-	ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> =1.5A	-	9	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time	R <sub>G</sub> =10Ω	-	27	-	ns
t <sub>f</sub>	Fall Time	V <sub>GS</sub> =10V	-	15	-	ns
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V	-	380	608	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =100V	-	15	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f=1.0MHz	-	6	-	pF
R <sub>g</sub>	Gate Resistance	f=1.0MHz	-	12	24	Ω

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
I <sub>S</sub>	Source Current ( Body Diode )	T <sub>C</sub> =25°C	-	-	1	A
V <sub>SD</sub>	Forward On Voltage <sup>2</sup>	I <sub>S</sub> =1A, V <sub>GS</sub> =0V	-	0.8	-	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =1.5A, V <sub>GS</sub> =0V	-	130	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt=100A/μs	-	610	-	nC

### Notes:

- 1.Pulse width limited by max. junction temperature.
- 2.Pulse test
- 3.TO-252 equivalent. Limited by max. junction temperature. Maximum duty cycle D=0.75
- 4.Starting T<sub>j</sub>=25°C , V<sub>DD</sub>=50V , L=100mH , R<sub>G</sub>=25Ω
- 5.I<sub>SD</sub> ≤ I<sub>D</sub>, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, starting T<sub>j</sub> = 25°C
- 6.Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board, t ≤10sec ; 160 °C/W when mounted on Min. copper pad.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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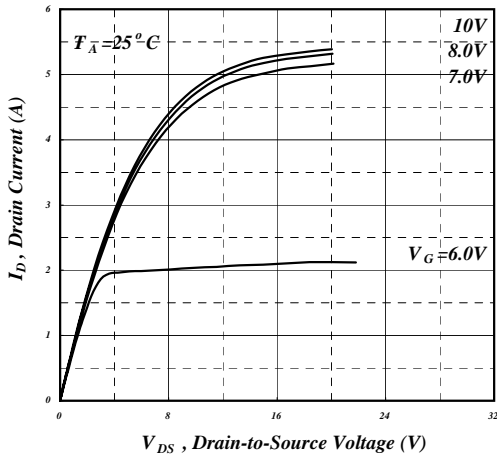


Fig 1. Typical Output Characteristics

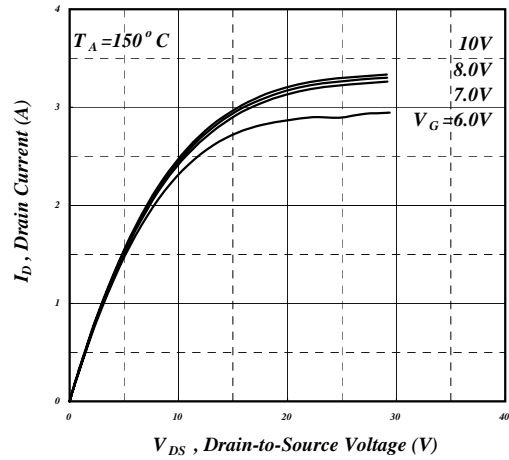


Fig 2. Typical Output Characteristics

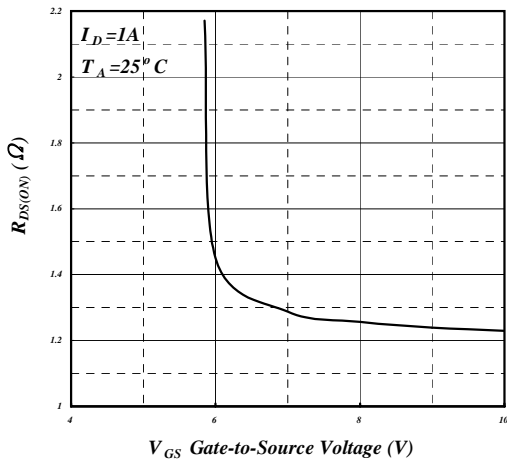


Fig 3. On-Resistance v.s. Gate Voltage

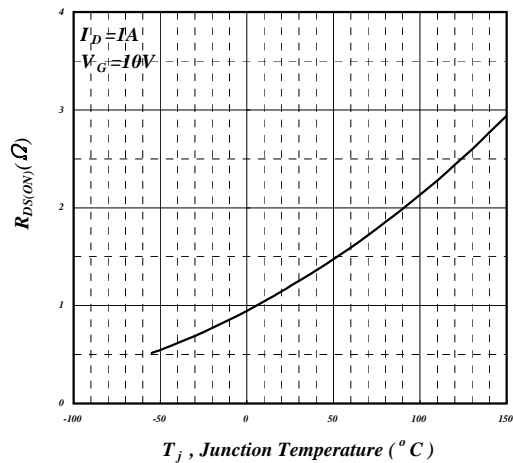


Fig 4. Static On-Resistance v.s. Junction Temperature

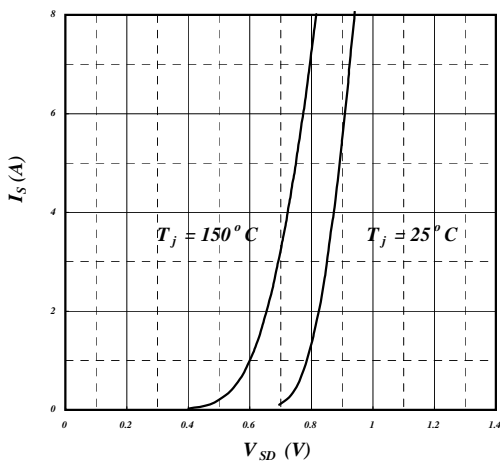


Fig 5. Forward Characteristic of Reverse Diode

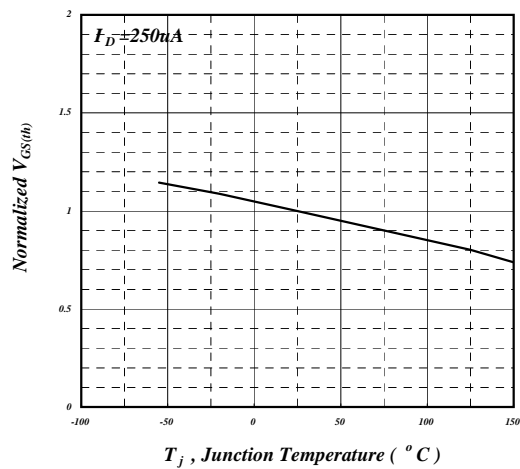


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

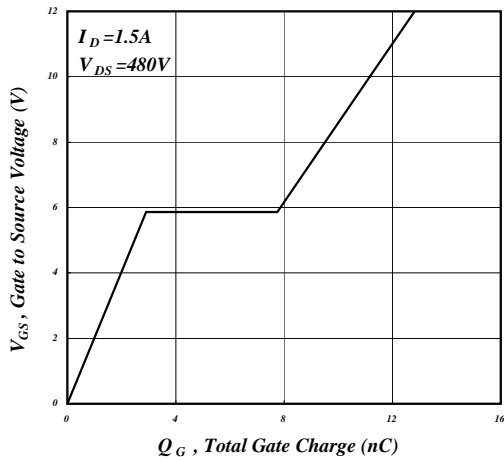


Fig 7. Gate Charge Characteristics

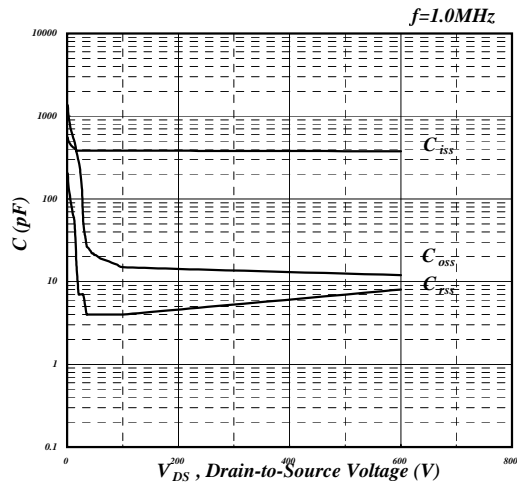


Fig 8. Typical Capacitance Characteristics

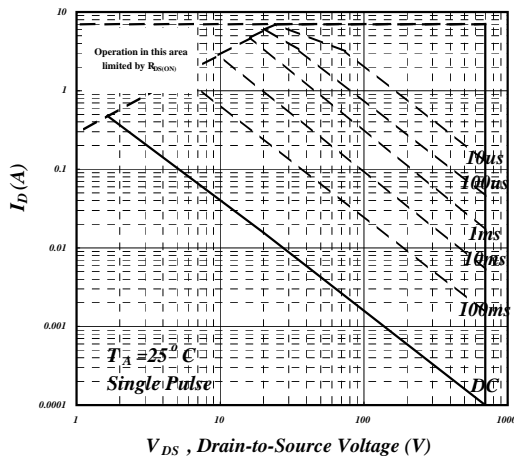


Fig 9. Maximum Safe Operating Area

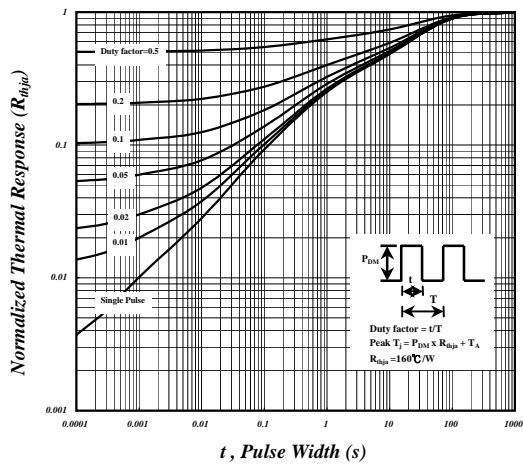


Fig 10. Effective Transient Thermal Impedance

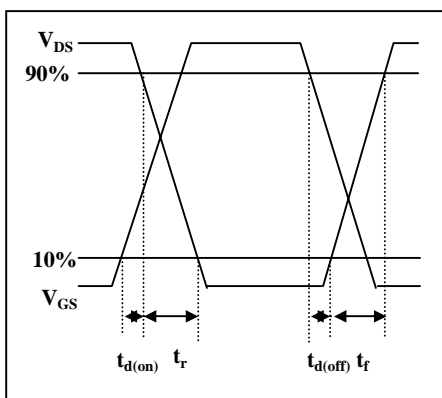


Fig 11. Switching Time Waveform

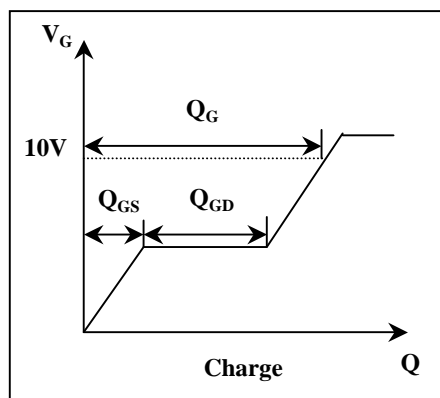


Fig 12. Gate Charge Waveform

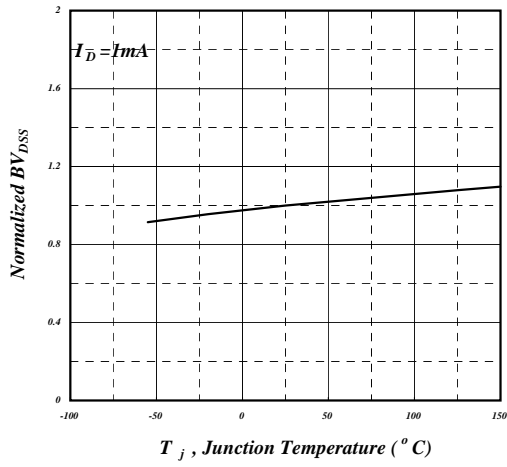


Fig 13. Normalized  $BV_{DSS}$  v.s. Junction Temperature

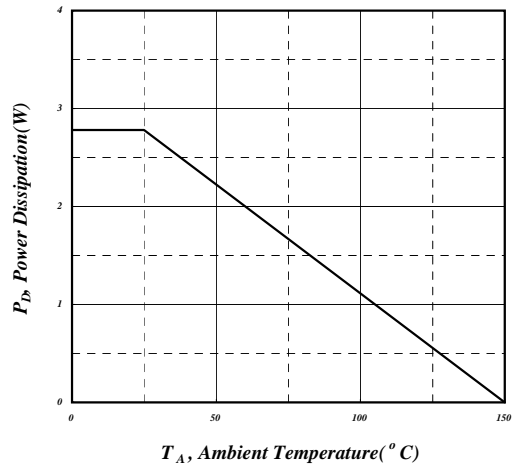


Fig 14. Total Power Dissipation

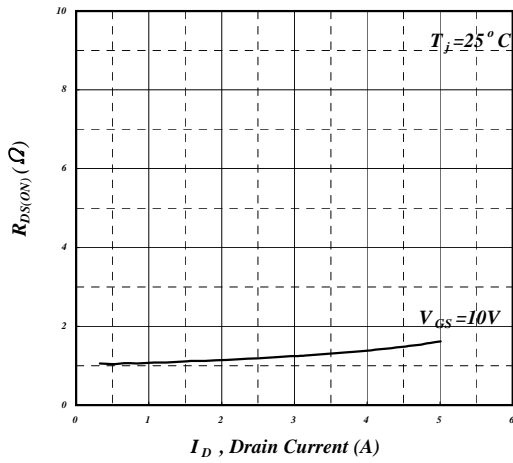


Fig 15. Typ. Drain-Source on State Resistance

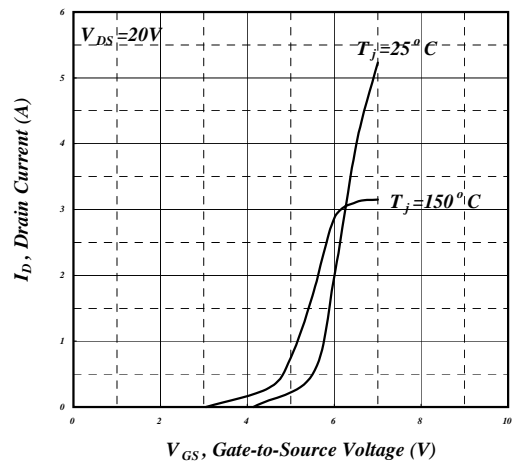


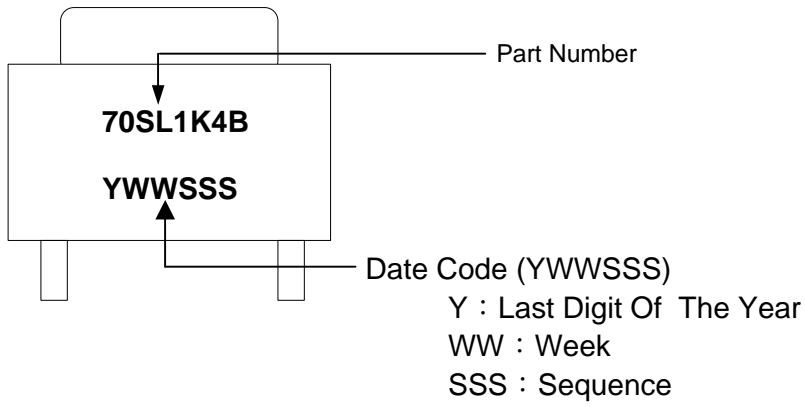
Fig 16. Transfer Characteristics



# AP70SL1K4BK2

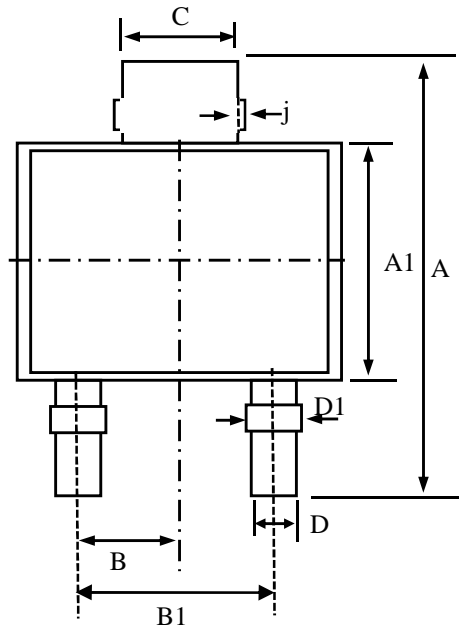
## MARKING INFORMATION

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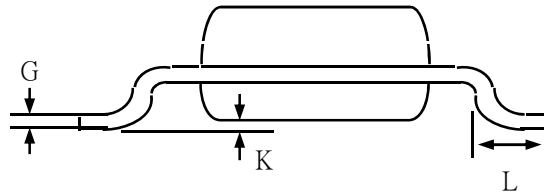
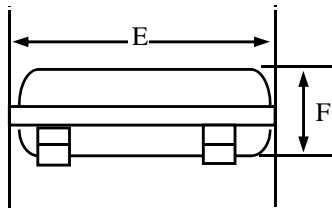




## Package Outline : SOT-223-2L



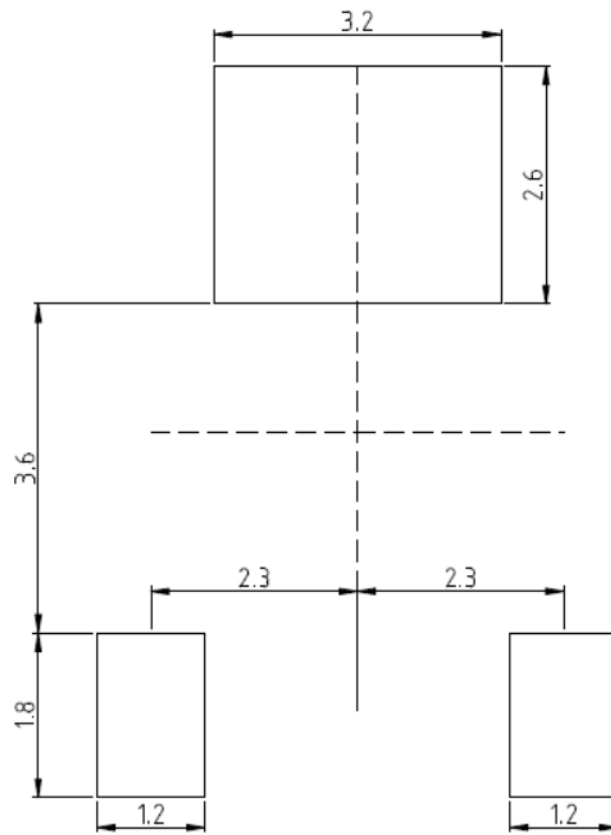
SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	6.70	7.00	7.30
B	---	2.30	---
B1	---	4.60	---
C	2.90	3.00	3.10
D	0.60	0.70	0.85
G	0.20	0.30	0.35
E	6.30	6.50	6.70
F	1.40	1.60	1.80
K	0.02	0.06	0.10
A1	3.30	3.50	3.70
L	0.50	0.75	1.00
D1	0.66	0.88	1.10
j			0.13



- 1.All Dimension Are In Millimeters.
- 2.Dimension Does Not Include Mold Protrusions.



SOT-223-2L FOOTPRINT :



UNIT: mm